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STD16NF25, STF16NF25, STP16NF25

N-channel 250 V, 0.195 Ω, 14 A STripFET™ II Power MOSFET in DPAK, TO-220FP and TO-220 packages

Datasheet - production data

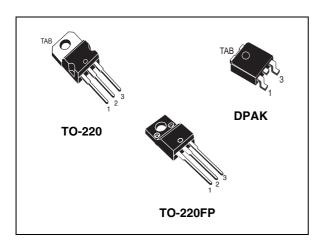
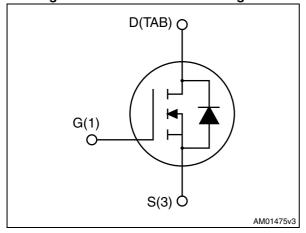


Figure 1. Internal schematic diagram



Features

Order codes	V _{DS}	R _{DS(on) max}	I _D	P _{TOT}
STD16NF25			14 A	100 W
STF16NF25	250 V	$0.235~\Omega$	14 A ⁽¹⁾	25 W
STP16NF25			14 A	100 W

- 1. Limited by maximum junction temperature
- · Exceptional dv/dt capability
- 100% avalanche tested
- Application oriented characterization

Applications

Switching applications

Description

These Power MOSFETs have been developed using STMicroelectronics' unique STripFET process, which is specifically designed to minimize input capacitance and gate charge. This renders the devices suitable for use as primary switch in advanced high-efficiency isolated DC-DC converters for telecom and computer applications, and applications with low gate charge driving requirements.

Table 1. Device summary

Order codes	Marking	Package	Packaging
STD16NF25		DPAK	Tape and reel
STF16NF25	16NF25	TO-220FP	Tube
STP16NF25		TO-220	Tube

Contents

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1 Electrical ratings

Table 2. Absolute maximum ratings

		Va		
Symbol	Parameter	DPAK TO-220	TO-220FP	Unit
V _{DS}	Drain-source voltage	2	50	V
V _{GS}	Gate- source voltage	±	20	V
I _D	Drain current (continuous) at T _C = 25 °C	14	14 ⁽¹⁾	Α
I _D	Drain current (continuous) at T _C = 100 °C	8.8	8.8 ⁽¹⁾	Α
I _{DM} ⁽²⁾	Drain current (pulsed)	56	56 ⁽¹⁾	Α
P _{TOT}	Total dissipation at T _C = 25 °C	85	25	W
	Derating factor	0.68	0.2	W/°C
dv/dt (3)	Peak diode recovery voltage slope	1	5	V/ns
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s;Tc = 25 °C)	2500		V
T _{stg}	Storage temperature	55 to 150		°C
T _j	Max. operating junction temperature	– -55 to 150 °C		

- 1. Limited by maximum junction temperature
- 2. Pulse width limited by safe operating area.
- $3. \quad I_{SD} \leq 13A, \; di/dt \; \leq 300A/\mu s, \; V_{DD} \; \leq \; 80\% \; V_{(BR)DSS}, \; Tj \; \leq T_{JMAX}$

Table 3. Thermal data

Symbol	Parameter	Value		Unit	
Symbol	r ai ailletei	TO-220	DPAK	TO-220FP	Offic
R _{thj-case}	Thermal resistance junction-case max	1.47		5	°C/W
R _{thj-pcb}	Thermal resistance junction to pcb max	50			°C/W
R _{thj-amb}	Thermal resistance junction-ambient max	62.5		62.5	°C/W

Table 4. Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not- repetitive (pulse width limited by $T_{j\;max}$)	13	А
E _{AS}	Single pulse avalanche energy (starting $T_j = 25$ °C, $I_{AR} = 13$ A, $V_{DD} = 50$ V)	100	mJ

2 Electrical characteristics

(T_C = 25 °C unless otherwise specified)

Table 5. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0$, $I_D = 1$ mA	250			V
	Zero gate voltage drain current	$V_{GS} = 0, V_{DS} = 250 \text{ V}$			1	μΑ
I _{DSS}		V _{GS} = 0, V _{DS} = 250 V, T _C =125 °C			10	μΑ
I _{GSS}	Gate-body leakage current	V _{DS} = 0, V _{GS} = ±20 V			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2	3	4	V
R _{DS(on)}	Static drain-source on- resistance	$V_{GS} = 10 \text{ V}, I_D = 6.5 \text{ A}$		0.195	0.235	Ω

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	680	-	pF
C _{oss}	Output capacitance	$V_{DS} = 25 \text{ V, f} = 1 \text{ MHz,}$	-	125	-	pF
C _{rss}	Reverse transfer capacitance	$V_{GS} = 0$	-	20	-	pF
Coss eq. (1)	Equivalent output capacitance	$V_{DS} = 0$ to 200 V, $V_{GS} = 0$	-	48	-	pF
R _G	Intrinsic gate resistance	f = 1 MHz, I _D = 0	-	2.1	-	Ω
Qg	Total gate charge	V _{DD} = 200 V, I _D = 13 A,	-	18	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V	-	3	-	nC
Q _{gd}	Gate-drain charge	(see Figure 19)	-	8	-	nC

^{1.} $C_{oss\ eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Table 7. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time		-	9	-	ns
t _r	Rise time	$V_{DD} = 125 \text{ V}, I_D = 6.5 \text{ A},$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$	-	17	-	ns
t _{d(off)}	Turn-off delay time	$ G_G = 4.752, V_{GS} = 10 V$ (see <i>Figure 18</i>)	-	35	-	ns
t _f	Fall time		-	17	-	ns

Table 8. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-	-	14	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-	-	56	Α
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 13 A, V _{GS} = 0	-	-	1.6	V
t _{rr}	Reverse recovery time	10 4 11/11 100 4/	-	133		ns
Q_{rr}	Reverse recovery charge	I _{SD} = 13 A, di/dt = 100 A/μs V _{DD} = 60 V (see <i>Figure 20</i>)	-	651		nC
I _{RRM}	Reverse recovery current	100 00 1 (000 1 1 9 010 2 0)	1	10		Α
t _{rr}	Reverse recovery time	I _{SD} = 13 A, di/dt = 100 A/μs	ı	157		ns
Q _{rr}	Reverse recovery charge	V _{DD} = 60 V, T _J =150 °C	-	895		nC
I _{RRM}	Reverse recovery current	(see <i>Figure 20</i>)	-	11		Α

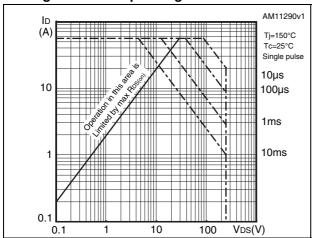
^{1.} Pulse width limited by safe operating area

^{2.} Pulsed: pulse duration = 300 μ s, duty cycle 1.5%.

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area for TO-220

Figure 3. Thermal impedance for TO-220



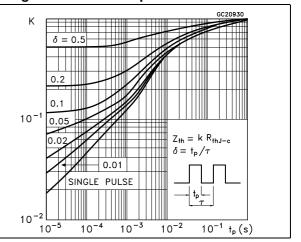
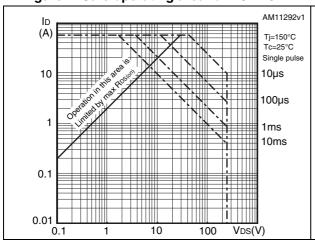


Figure 4. Safe operating area for TO-220FP

Figure 5. Thermal impedance for TO-220FP



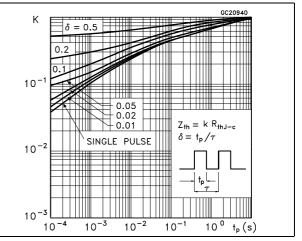
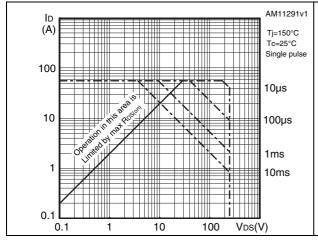


Figure 6. Safe operating area for DPAK

Figure 7. Thermal impedance for DPAK



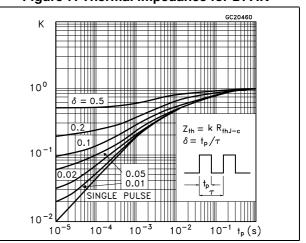


Figure 8. Output characteristics

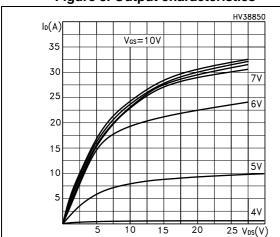


Figure 9. Transfer characteristics

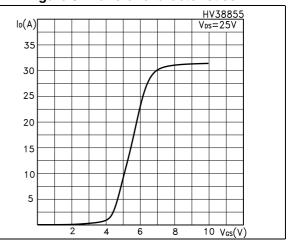


Figure 10. Normalized BV_{DSS} vs temperature

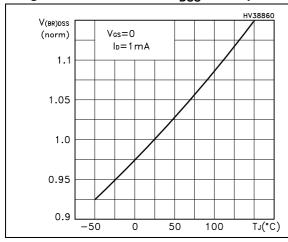


Figure 11. Static-drain source on-resistance

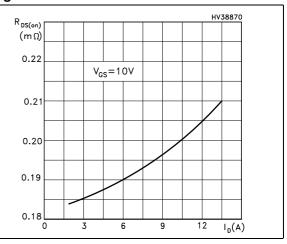


Figure 12. Gate charge vs gate-source voltage

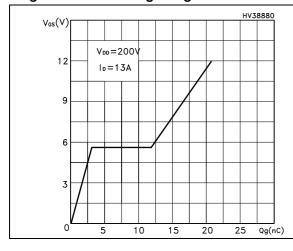


Figure 13. Capacitance variations

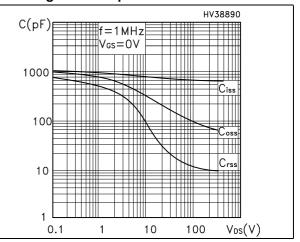


Figure 14. Normalized gate threshold voltage vs temperature

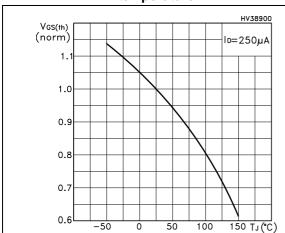


Figure 15. Normalized on-resistance vs temperature

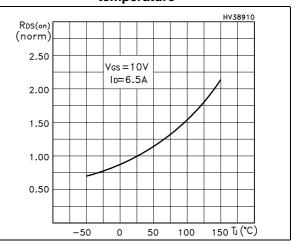


Figure 16. Source-drain diode forward characteristics

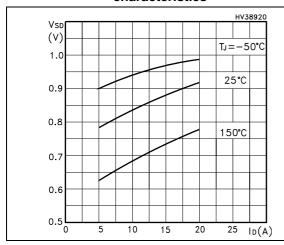
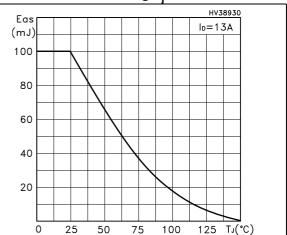


Figure 17. Maximum avalanche energy vs starting T_i



3 Test circuit

Figure 18. Switching times test circuit for resistive load

Figure 19. Gate charge test circuit

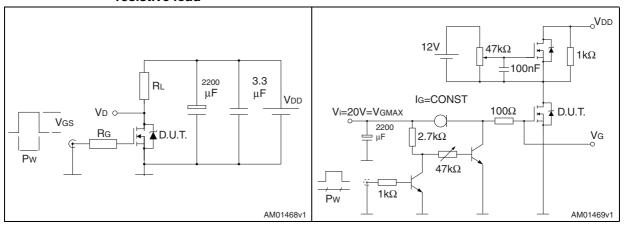


Figure 20. Test circuit for inductive load switching and diode recovery times

Figure 21. Unclamped inductive load test circuit

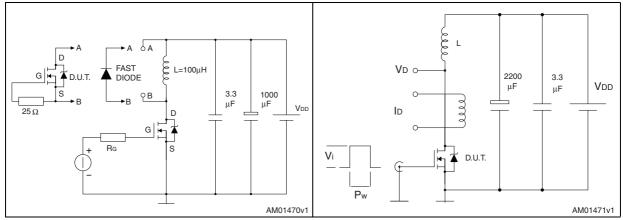
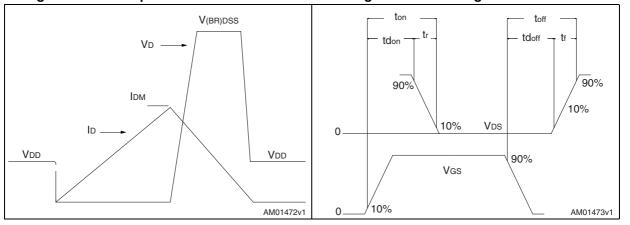


Figure 22. Unclamped inductive waveform

Figure 23. Switching time waveform



4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.

Table 9. DPAK (TO-252) mechanical data

mm						
Dim.			1			
	Min.	Тур.	Max.			
Α	2.20		2.40			
A1	0.90		1.10			
A2	0.03		0.23			
b	0.64		0.90			
b4	5.20		5.40			
С	0.45		0.60			
c2	0.48		0.60			
D	6.00		6.20			
D1		5.10				
Е	6.40		6.60			
E1		4.70				
е		2.28				
e1	4.40		4.60			
Н	9.35		10.10			
L	1.00		1.50			
(L1)		2.80				
L2		0.80				
L4	0.60		1.00			
R		0.20				
V2	0°		8°			

E -THERMAL PAD c2 *L2* D1 Н **b**(2x) R C SEATING PLANE (L1) *V2* GAUGE PLANE 0,25 0068772_K

Figure 24. DPAK (TO-252) drawing

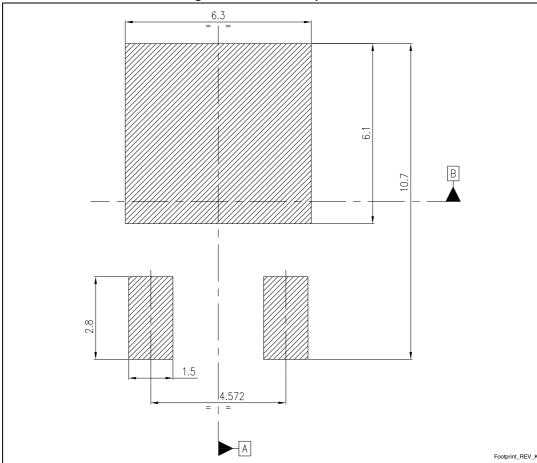


Figure 25. DPAK footprint (a)

a. All dimensions are in millimeters

Table 10. TO-220FP mechanical data

		mm	
Dim.	Min.	Тур.	Max.
Α	4.4		4.6
В	2.5		2.7
D	2.5		2.75
E	0.45		0.7
F	0.75		1
F1	1.15		1.70
F2	1.15		1.70
G	4.95		5.2
G1	2.4		2.7
Н	10		10.4
L2		16	
L3	28.6		30.6
L4	9.8		10.6
L5	2.9		3.6
L6	15.9		16.4
L7	9		9.3
Dia	3		3.2

-*B*-Dia L6 L2 *L7* L3 F1 **L4** F2 Ε -G1-7012510_Rev_K_B

Figure 26. TO-220FP drawing

Table 11. TO-220 type A mechanical data

Dim	mm				
Dim. —	Min.	Тур.	Max.		
Α	4.40		4.60		
b	0.61		0.88		
b1	1.14		1.70		
С	0.48		0.70		
D	15.25		15.75		
D1		1.27			
E	10		10.40		
е	2.40		2.70		
e1	4.95		5.15		
F	1.23		1.32		
H1	6.20		6.60		
J1	2.40		2.72		
L	13		14		
L1	3.50		3.93		
L20		16.40			
L30		28.90			
ØP	3.75		3.85		
Q	2.65		2.95		

D D1 L30 D1 L30

Figure 27. TO-220 type A drawing

5 Packaging mechanical data

Table 12. DPAK (TO-252) tape and reel mechanical data

Таре				Reel		
Dim.	n	nm	Dim.	mm		
	Min.	Max.	— Dilli.	Min.	Max.	
A0	6.8	7	Α		330	
В0	10.4	10.6	В	1.5		
B1		12.1	С	12.8	13.2	
D	1.5	1.6	D	20.2		
D1	1.5		G	16.4	18.4	
Е	1.65	1.85	N	50		
F	7.4	7.6	Т		22.4	
K0	2.55	2.75			•	
P0	3.9	4.1		Base qty.	2500	
P1	7.9	8.1		Bulk qty.	2500	
P2	1.9	2.1			•	
R	40					
Т	0.25	0.35				
W	15.7	16.3				

10 pitches cumulative tolerance on tape +/- 0.2 mm
Top cover tape

For machine ref. only including draft and radii concentric around B0

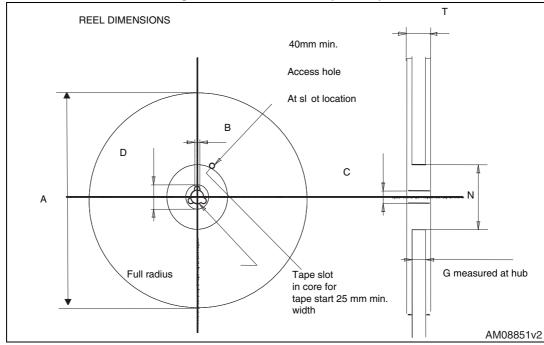
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Figure 28. Tape for DPAK (TO-252)





6 Revision history

Table 13. Document revision history

Date	Revision	Changes	
12-Oct-2007	1	Initial release.	
13-Nov-2007	2	Modified: Figure 13: Capacitance variations.	
29-Mar-2012	3	Figure 2: Safe operating area for TO-220, Figure 4: Safe operating area for TO-220FP and Figure 6: Safe operating area for DPAK have been updated. Section 4: Package mechanical data and Section 5: Packaging mechanical data have been updated. Minor text changes	
06-Mar-2013	4	 Modified: P_{TOT}, derating factor values, note 1 on Table 2, R_{thj-case}, R_{thj-amb} only for TO-220 and DPAK Updated: Section 4: Package mechanical data Minor text changes 	

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